



Sheet 1 of 1

Based on FORM 1449 (3/90)		ATTY. DOCKET NO. 450100-04774	SERIAL NO. 10/527,137
APPLICANT Tatsuya DEGUCHI et al.			
FILING DATE March 8, 2005		GROUP 2612	

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
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	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/A.H./	AL	2001 311977	11/09/01	Japan			YES
/A.H./	AM	2002 209138	07/26/02	Japan			YES
	AN						
	AO						
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AQ						
	AR						
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EXAMINER /Amy Hsu/				DATE CONSIDERED 09/17/2007			

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Based on Form PTO-1449 (3/90)		ATTY. DOCKET NO. 450100-04774	SERIAL NO. Filed Concurrently Herewith
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT Tatsuya DEGUCHI et al.	
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U.S. PATENT DOCUMENTS							
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	AA						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/A.H./	AI	JP 2002-92607	03/29/02	Japan			
	AJ	JP 2002-238013	08/23/01	Japan			
	AK	JP 2001-285641	10/12/01	Japan			
	AL	JP 2000-307896	11/02/00	Japan			
	AM	JP 11-298792	10/29/99	Japan			
	AN	JP 9-93464	04/04/97	Japan			
	AO						
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AQ		Tetsuro KUWAYAMA, "IEC TC100 no Doko, The Institute of Image Electronics Engineers of Japan, 25 January, 2001, Vol. 30, No. 1, pages 30 to 34				
	AR						
	AS						

EXAMINER	DATE CONSIDERED
/Amy Hsu/	09/17/2007

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Based on Form PTO-1449 (3/90)		ATTY. DOCKET NO. 450100-04774	INT'L APPL. NO. PCT/JP03/10779
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT Tatsuya DEGUCHI et al.	
		INT'L FILING DATE August 26, 2003	GROUP 2612

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/A.H./	AA	2002 0024609	02/28/02	Matsushima			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/A.H./	AL	JP 2002 238013	08/23/02	Japan			X
/A.H./	AM	JP 2000 307896	11/02/00	Japan			X
/A.H./	AN	JP 11 298792	10/29/99	Japan			X
/A.H./	AO	JP 9 93464	04/04/97	Japan			X
/A.H./	AP	JP 2001 285641	10/12/01	Japan			X

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